

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/814,821	ICHIKAWA ET AL.	
Examiner	Art Unit	
Yaima Campos	2185	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				

SEARCH NO	res			
(INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EIC PLUS search	3/29/2006	YC		
PALM and EAST inventor name search	3/29/2006	YC		
Text search withing subclasses 711/113,118,133-135	3/29/2006	YC		
Text search within classes 707, 709 and 711	3/29/2006	YC		